Applicant(s)/Patent Under Reexamination Application/Control No. 10/724,072 CHUNG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 M. R. Sedighian 2613 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-6,813,021 11-2004 Chung et al. 356/364 Α US-В US-С D US-US-Ε US-F US-G

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т	,				

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	V						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Н

J

Κ

М

US-US-

US-

US-US-